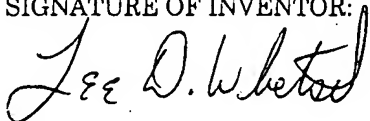


TITLE OF INVENTION: Probeless Testing Of Pad Buffers On Wafer		
POWER OF ATTORNEY:      I HEREBY APPOINT THE FOLLOWING ATTORNEYS TO PROSECUTE THIS APPLICATION AND TRANSACT ALL BUSINESS IN THE PATENT AND TRADEMARK OFFICE CONNECTED THEREWITH		
Lawrence J. Bassuk, Reg. No. 29,043      Richard L. Donaldson, Reg. No. 25,673 William W. Holloway, Reg. No. 26,182      W. James Brady, III, Reg. No. 32,080 William B. Kempler, Reg. No. 28,228      Jay M. Cantor, Reg. No. 19,906		
SEND CORRESPONDENCE TO: Lawrence J. Bassuk Texas Instruments Incorporated P.O. Box 655474 M/S 3999 Dallas, Texas 75265		DIRECT TELEPHONE CALLS TO:  Lawrence J. Bassuk (972) 917-5458
NAME OF INVENTOR: (1) Lee D. Whetsel	NAME OF INVENTOR: (2)	NAME OF INVENTOR: (3)
RESIDENCE (City and State Only) Allen, Texas	RESIDENCE (City and State Only)	RESIDENCE (City and State Only)
Post Office Address 512 Bullingham Allen, Texas 75002	Post Office Address	Post Office Address
COUNTRY OF CITIZENSHIP: U.S.A.	COUNTRY OF CITIZENSHIP:	COUNTRY OF CITIZENSHIP:
SIGNATURE OF INVENTOR: 	SIGNATURE OF INVENTOR:	SIGNATURE OF INVENTOR:
DATE: 6-29-98	DATE:	DATE: